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DIODES, MICROWAVE, SILICON, PIN, FAST SWITCHING, BASED ON TYPES ML4627P TO ML4629P ESCC Detail Specification No. 5513/019

ISSUE 1 October 2002





ESCC Detail Specification

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DIODES, MICROWAVE, SILICON, PIN, FAST SWITCHING, BASED ON TYPES ML4627P TO ML4629P ESA/SCC Detail Specification No. 5513/019



space components coordination group

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Issue/Rev.	Date	SCCG Chairman	ESA Director General or his Deputy,
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DOCUMENTATION CHANGE NOTICE

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Rev. Letter	Rev. Date	Reference	CHANGE Item	Approved DCR No.
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APPENDICES (Applicable to specific Manufacturers only)

None.



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1. GENERAL

1.1 SCOPE

This specification details the ratings, physical and electrical characteristics, test and inspection data for a Diode, Microwave, Silicon, PIN, Fast Switching, based on Types ML4627P to ML4629P. It shall be read in conjunction with ESA/SCC Generic Specification No. 5010, the requirements of which are supplemented herein.

1.2 TYPE VARIANTS

Variants of the basic diodes specified herein, which are also covered by this specification are given in Table 1(a).

1.3 MAXIMUM RATINGS

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the diodes specified herein, are as scheduled in Table 1(b).

1.4 PARAMETER DERATING INFORMATION

The derating information applicable to the diodes specified herein is shown in Figure 1.

1.5 PHYSICAL DIMENSIONS

The physical dimensions of the diodes specified herein are shown in Figure 2.

1.6 FUNCTIONAL DIAGRAM

The functional diagram, showing lead identification, of the diodes specified herein, is shown in Figure 3.

1.7 HANDLING PRECAUTIONS

These devices are susceptible to damage by electrostatic discharge. Therefore, suitable precautions shall be employed for protection during all phases of manufacture, testing, packaging, shipment and any handling.

These components are Categorised as Class 2 with a Minimum Critical Path Failure Voltage of 4200V.

2. APPLICABLE DOCUMENTS

The following documents form part of this specification and shall be read in conjunction with it:-

- (a) ESA/SCC Generic Specification No. 5010 for Discrete Microwave Semiconductor Components.
- (b) MIL-STD-750, Test Methods and Procedures for Semiconductor Devices.

3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESA/SCC Basic Specification No. 21300 shall apply.



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TABLE 1(a) - TYPE VARIANTS

(1) VARIANT	(2) BASED ON TYPE	(3) FIGURE	TOTAL CAP C _T (JUNCTION CAPACITANCE	(6) BODY-LID AND LEAD
	IYPE		MIN	MAX	C _J (pF) (Typical)	MATERIAL AND FINISH
01	ML4627P - 30	2(a)	0.25	0.35	0.1	A7-D2
02	ML4627P - 31	2(b)	0.25	0.35	0.1	A7-D2
03	ML4627P - 32	2(c)	0.36	0.46	0.1	A7-D2
04	ML4627P - 34	2(d)	0.45	0.55	0.1	A7-D2
05	ML4627P - 36	2(e)	0.25	0.35	0.1	A7-D2
06	ML4627P - 43	2(f)	0.85	0.95	0.1	A7-D2
07	ML4627P - 56	2(g)	0.58	0.68	0.1	A7-D2
08	ML4627P - 91	2(h)	0.36	0.46	0.1	A7-D2
09	ML4627P - 92	2(i)	0.36	0.46	0.1	A7-D2
10	ML4627P - 94	2(j)	0.23	0.33	0.1	A7-D2
11	ML4627P - 95	2(k)	0.23	0.33	0.1	A7-D2
12	ML4627P - 96	2(l)	0.23	0.33	0.1	A7-D2
13	ML4627P - 97	2(m)	0.23	0.33	0.1	A7-D2
14	ML4627P - 101	2(n)	0.55	0.65	0.1	A7-D2
15	ML4627P - 103	2(0)	0.36	0.46	0.1	A7-D2
16	ML4627P - 118	2(p)	0.30	0.40	0.1	A 7
17	ML4627P - 120	2(q)	0.21	0.31	0.1	D2
18	ML4627P - 128	2(r)	0.31	0.41	0.1	A7-D2
19	ML4627P - 138	2(s)	0.26	0.36	0.1	A 7
20	ML4627P - 148	2(t)	0.34	0.44	0.1	A7
21	ML4627P - 255	2(u)	0.35	0.45	0.1	A7
22	ML4627P - 275	2(v)	0.43	0.53	0.1	A 7
23	ML4627P - 276	2(w)	0.21	0.31	0.1	D2
24	ML4627P - 186	2(x)	0.20	0.30	0.1	D2
25	ML4628P - 30	2(a)	0.30	0.50	0.2	A7-D2
26	ML4628P - 31	2(b)	0.30	0.50	0.2	A7-D2
27	ML4628P - 32	2(c)	0.41	0.61	0.2	A7-D2
28	ML4628P - 34	2(d)	0.50	0.70	0.2	A7-D2
29	ML4628P - 36	2(e)	0.30	0.50	0.2	A7-D2
30	ML4628P - 43	2(f)	0.90	1.10	0.2	A7-D2
31	ML4628P - 56	2(g)	0.63	0.83	0.2	A7-D2
32	ML4628P - 91	2(h)	0.41	0.61	0.2	A7-D2
33	ML4628P - 92	2(i)	0.41	0.61	0.2	A7-D2
34	ML4628P - 101	2(n)	0.60	0.80	0.2	A7-D2
35	ML4628P - 103	2(0)	0.41	0.61	0.2	A7-D2
36	ML4628P - 255	2(u)	0.40	0.60	0.2	A 7
37	ML4628P - 186	2(x)	0.25	0.45	0.2	D2



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TABLE 1(a) - TYPE VARIANTS (CONT'D)

(1) VARIANT	(2) BASED ON TYPE	(3) FIGURE	TOTAL CAP C _T ((5) JUNCTION CAPACITANCE C _J (pF)	(6) BODY-LID AND LEAD MATERIAL
			MIN	MAX	(Typical)	AND FINISH
38	ML4629P - 30	2(a)	0.40	0.60	0.3	A7-D2
39	ML4629P - 31	2(b)	0.40	0.60	0.3	A7-D2
40	ML4629P - 32	2(c)	0.51	0.71	0.3	A7-D2
41	ML4629P - 34	2(d)	0.60	0.80	0.3	A7-D2
42	ML4629P - 36	2(e)	0.40	0.60	0.3	A7-D2
43	ML4629P - 43	2(f)	1.00	1.20	0.3	A7-D2
44	ML4629P - 56	2(g)	0.73	0.93	0.3	A7-D2
45	ML4629P - 91	2(h)	0.51	0.71	0.3	A7-D2
46	ML4629P - 92	2(i)	0.51	0.71	0.3	A7-D2
47	ML4629P - 101	2(n)	0.70	0.90	0.3	A7-D2
48	ML4629P - 103	2(0)	0.51	0.71	0.3	A7-D2
49	ML4629P - 255	2(u)	0.50	0.70	0.3	A7
50	ML4629P - 186	2(x)	0.35	0.55	0.3	D2



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TABLE 1(b) - MAXIMUM RATINGS

No.	CHARACTERISTIC	SYMBOL	MAXIMUM RATINGS	UNIT	REMARKS
1	D.C. Reverse Voltage	V _R	- 200	V	Note 1
2	D.C. Forward Current (Continuous)	lF	200	mA	Note 2
3	R.F. Power Dissipation Variants 01 to 23 Variant 24 Variants 25 to 36 Variant 37 Variants 38 to 49 Variant 50	P _{tot}	3.1 0.6 3.5 0.6 4.1 0.6	W	Note 1
4	Operating Temperature Range	T _{op}	-65 to +150	°C	T _{case}
5	Storage Temperature Range	T _{stg}	-65 to +150	°C	
6	Soldering Temperature	T _{sol}	+ 230	°C	Note 3

NOTES

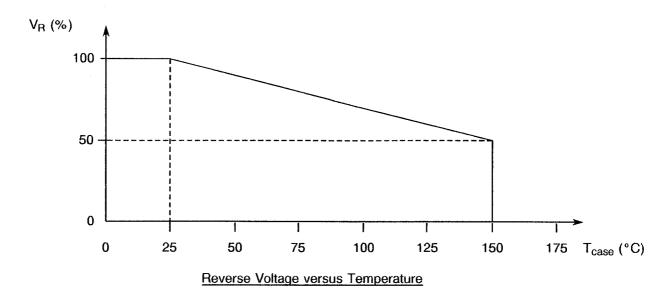
- 1. At $T_{case} = +25$ °C. For derating at $T_{case} > +25$ °C, see Figure 1.
- 2. At T_{case} = +100°C. For derating at T_{case} > +100°C, see Figure 1.
- 3. Duration 5 seconds maximum (at a distance of not less than 1.5mm from the body for Variants 23, 24, 37 and 50) and the same termination shall not be resoldered until 3 minutes have elapsed.

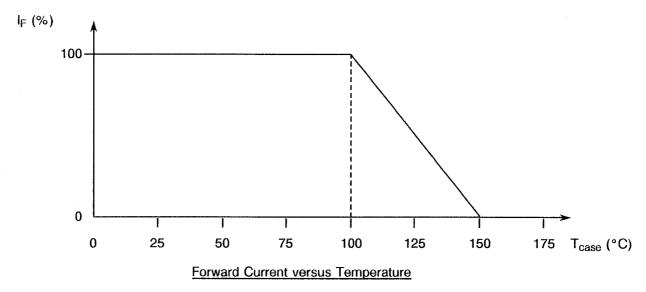


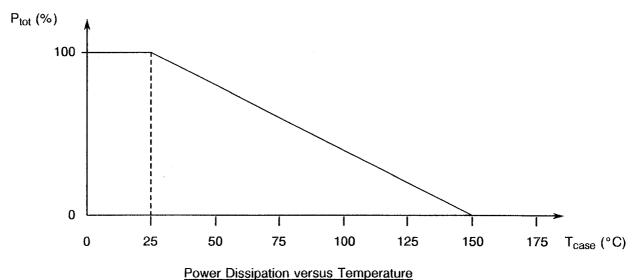
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FIGURE 1 - PARAMETER DERATING INFORMATION







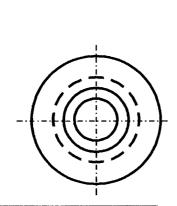


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FIGURE 2 - PHYSICAL DIMENSIONS

FIGURE 2(a) - VARIANTS 01, 25, 38



	← L>	 [3 > > B1	←	
ØD1 Ød	B2->-	A-	Catho	ode end	ØD

SYMBOL	MILLIMETRES		
STVIBOL	MIN	MAX	
Α	5.20	5.72	
В	2.16	2.46	
B1	0.41	0.61	
B2	0.15	0.25	
Ød	1.52	1.63	
ØD	3.00	3.23	
ØD1	1.95	2.11	
L	1.52	1.63	

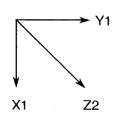
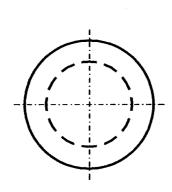
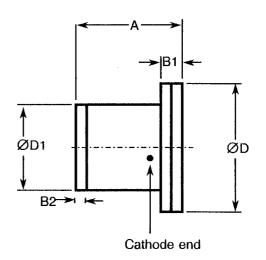
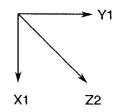


FIGURE 2(b) - VARIANTS 02, 26, 39



SYMBOL	MILLIMETRES		
STIVIBUL	MIN	MAX	
Α	2.16	2.46	
B1	0.41	0.61	
B2	0.15	0.25	
ØD	3.00	3.23	
ØD1	1.95	2.11	





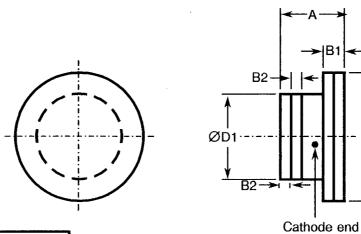


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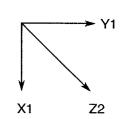
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FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(c) - VARIANTS 03, 27, 40

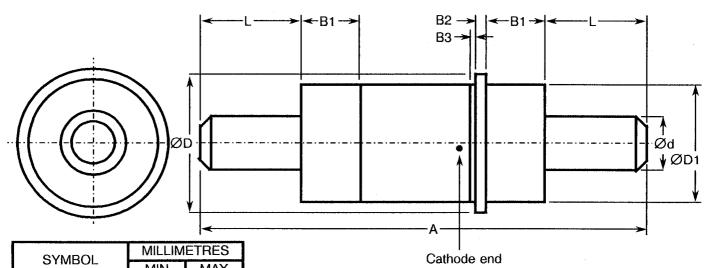


SYMBOL.	MILLIMETRES		
STVIBOL	MIN	MAX	
Α	1.37	1.68	
B1	0.41	0.61	
B2	0.15	0.20	
ØD	3.00	3.23	
ØD1	1.95	2.11	

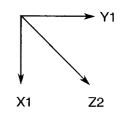


ØD

FIGURE 2(d) - VARIANTS 04, 28, 41



SYMBOL	MILLIMETRES	
STWIBOL	MIN	MAX
Α	19.45	20.12
B1	2.54	-
B2	0.53	0.83
B3	0.19	0.41
Ød	2.33	2.44
ØD	-	6.10
ØD1	5.20	5.46
L	4.57	4.83



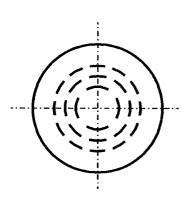


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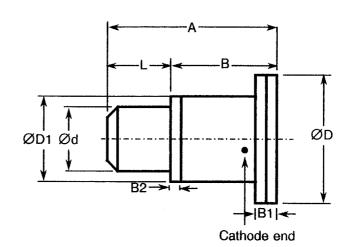
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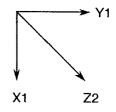
FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(e) - VARIANTS 05, 29, 42



SYMBOL	MILLIMETRES	
STVIDOL	MIN	MAX
Α	3.60	4.18
В	2.16	2.46
B1	0.41	0.61
B2	0.15	0.25
Ød	1.52	1.63
ØD	3.00	3.23
ØD1	1.95	2.11
L	1.52	1.63





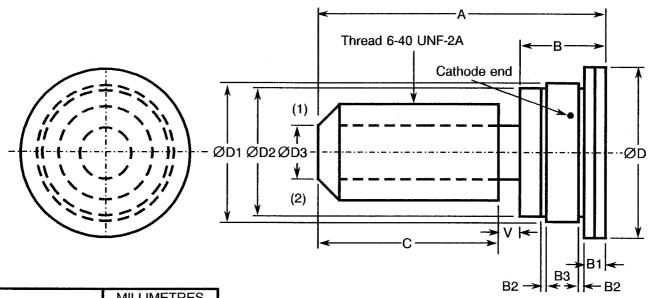


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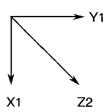
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FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(f) - VARIANTS 06, 30, 43



SYMBOL	MILLIMETRES	
STWIBOL	MIN	MAX
Α	11.18	11.68
В	3.02	3.66
B1	0.64	0.89
B2	0.18	0.23
B3	1.17	1.27
С	6.50	7.90
ØD	6.48	6.73
ØD1	5.20	5.50
ØD2	4.80	5.20
ØD3	2.00	2.70
V	0.76	1.02



NOTES

- 1. Spline socket to fit spline key 1.78mm deep.
- 2. 0.51mm x 45°.

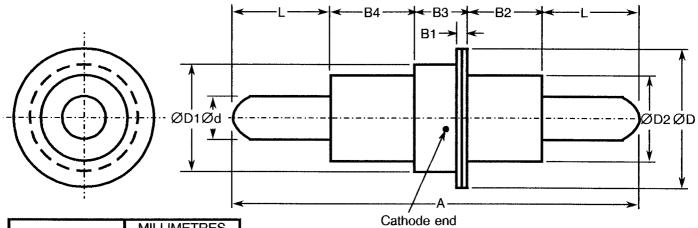


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FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(g) - VARIANTS 07, 31, 44



SYMBOL	MILLIMETRES	
STWIDOL	MIN	MAX
Α	19.46	20.12
B1	-	0.76
B2	3.00	3.60
B3	2.41	2.67
B4	3.68	3.94
Ød	2.33	2.39
ØD	-	6.10
ØD1	4.72	4.83
ØD2	3.81	4.19
L	4.57	4.83

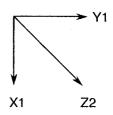
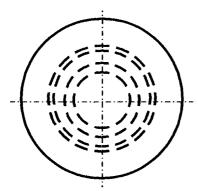
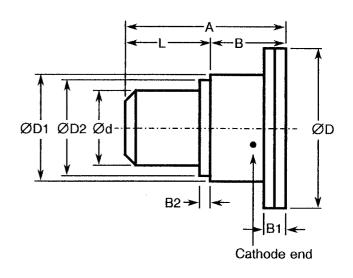
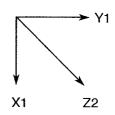


FIGURE 2(h) - VARIANTS 08, 32, 45



SYMBOL	MILLIN	MILLIMETRES	
STIVIDOL	MIN	MAX	
Α	2.92	3.28	
В	1.40	1.65	
B1	0.41	0.61	
B2	0.15	0.20	
Ød	1.52	1.63	
ØD	3.00	3.23	
ØD1	1.95	2.11	
ØD2	1.85	2.03	
L	1.52	1.63	





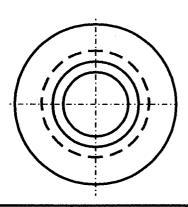


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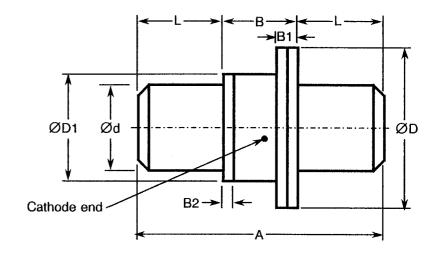
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FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(i) - VARIANTS 09, 33, 46



SYMBOL	MILLIMETRES	
STVIDOL	MIN	MAX
Α	4.42	4.93
В	1.40	1.65
B1	0.41	0.61
B2	0.15	0.20
Ød	1.52	1.63
ØD	3.00	3.23
ØD1	1.95	2.11
L	1.52	1.63



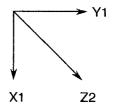
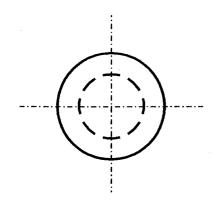
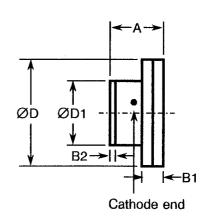
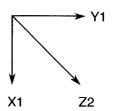


FIGURE 2(j) - VARIANT 10



SYMBOL	MILLIMETRES	
STIVIDUL	MIN	MAX
Α	1.02	1.27
B1	-	0.38
B2	0.10	0.25
ØD	1.98	2.18
ØD1	1.19	1.35





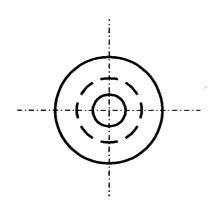


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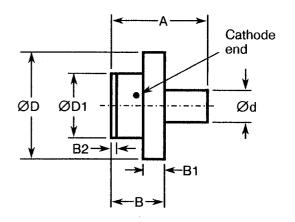
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FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(k) - VARIANT 11



SYMBOL	MILLIMETRES	
3 TIVIBOL	MIN	MAX
Α	1.78	2.03
В	1.02	1.27
B1	-	0.38
B2	0.10	0.25
Ød	0.61	0.66
ØD	1.98	2.18
ØD1	1.19	1.35



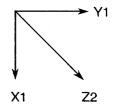
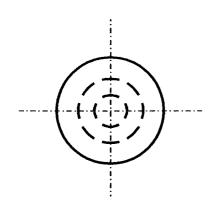
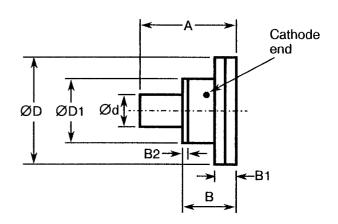
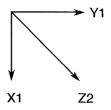


FIGURE 2(I) - VARIANT 12



SYMBOL	MILLIMETRES	
3 TIVIBOL	MIN	MAX
Α	1.78	2.03
В	1.02	1.27
B1	-	0.38
B2	0.10	0.25
Ød	0.61	0.66
ØD	1.98	2.18
ØD1	1.19	1.35





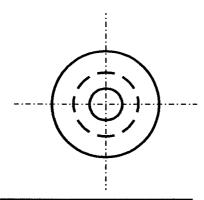


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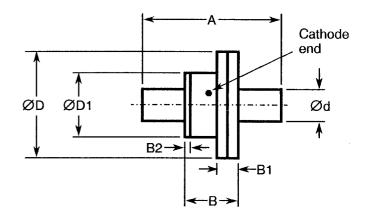
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FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(m) - VARIANT 13



SYMBOL	MILLIMETRES	
3 TIVIDOL	MIN	MAX
Α	2.54	2.79
В	1.02	1.27
B1	-	0.38
B2	0.10	0.25
Ød	0.61	0.66
ØD	1.98	2.18
ØD1	1.19	1.35



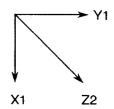
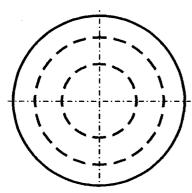


FIGURE 2(n) - VARIANTS 14, 34, 47



SYMBOL	MILLIMETRES	
STIVIBUL	MIN	MAX
Α	5.34	5.74
В	2.52	2.72
B1	0.61	0.81
B2	0.65	0.85
С	1.68	2.58
ØD	4.03	4.09
ØD1	3.05	3.25
ØD2	1.60	2.00
V	0.64	0.94

D1 ØD2 OD (1) Thread 3-48 UNC-2A Cathode end

X1

Z2

NOTES

1. 6 spline socket, 1.39mm deep.

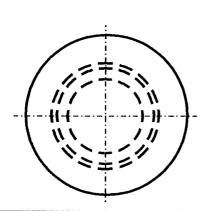


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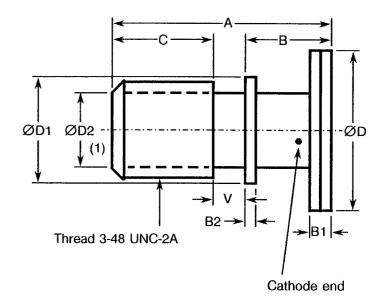
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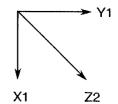
FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(o) - VARIANTS 15, 35, 48



SYMBOL	MILLIMETRES	
3 TIVIDOL.	MIN	MAX
Α	4.71	5.30
В	1.47	1.80
B1	0.41	0.61
B2	0.20	0.30
С	1.97	3.19
ØD	3.00	3.23
ØD1	2.49	2.59
ØD2	1.60	2.00
V	0.64	0.94

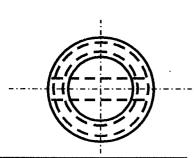




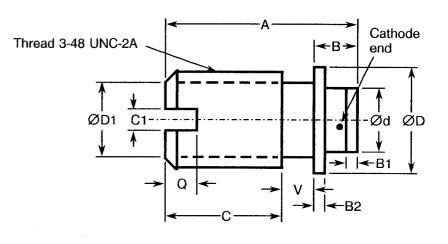
NOTES

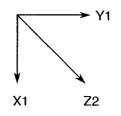
1. 6 spline socket, 1.39mm deep.

FIGURE 2(p) - VARIANT 16



SYMBOL	MILLIMETRES	
STWIDOL	MIN	MAX
Α	4.19	4.70
В	0.77	1.04
B1	0.20	0.30
B2	0.22	0.28
C	2.21	3.29
C1	0.38	0.64
Ød	1.22	1.32
ØD	2.49	2.59
ØD1	1.60	2.00
Q	0.64	1.14
V	0.64	0.94





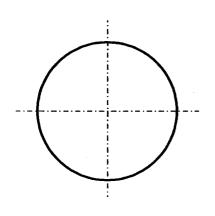


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FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(q) - VARIANT 17



		Α		>
Cathode end			•	ØD
	B2→	-	→ B	1 🖛

SYMBOL	MILLIMETRES	
STWIDOL	MIN	MAX
Α	1.02	1.27
B1	0.23	0.33
B2	0.10	0.15
ØD	1.29	1.40

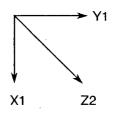
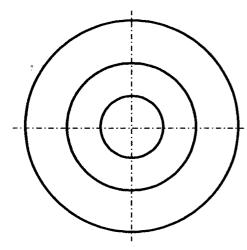
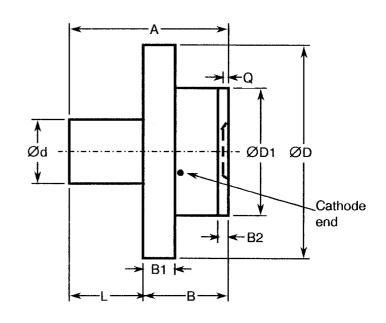
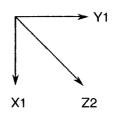


FIGURE 2(r) - VARIANT 18



SYMBOL	MILLIMETRES	
3 TIVIDUL	MIN	MAX
Α	1.384	1.715
В	0.749	0.826
B1	0.025	0.038
B2	0.05	0.18
Ød	0.56	0.71
ØD	1.96	2.11
ØD1	1.19	1.35
Q	0.038	0.076
L	0.558	0.996





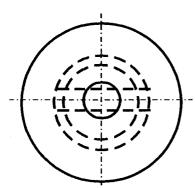


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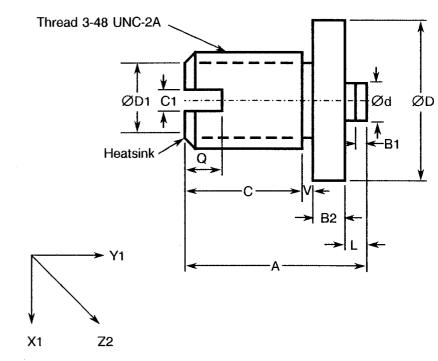
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FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(s) - VARIANT 19



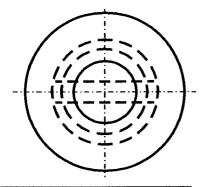
SYMBOL	MILLIMETRES	
3 TIVIDOL.	MIN	MAX
Α	3.56	3.68
B1	0.20	0.30
B2	0.46	0.56
С	2.36	3.02
C1	0.38	0.64
Ød	0.69	0.86
ØD	2.87	3.00
ØD1	1.60	2.00
L	0.41	0.48
Q	0.64	1.14
V	0.20	0.64



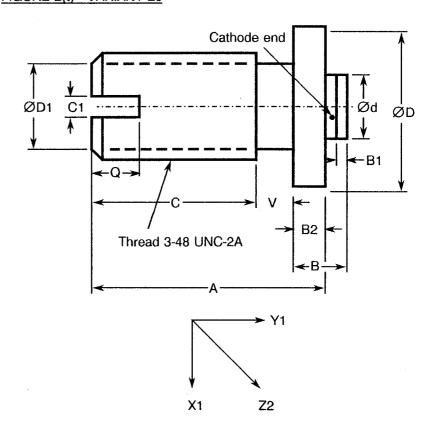
NOTES

1. Due to its very small size, not even the cathode identification will be marked on this package (see Para. 4.5.1).

FIGURE 2(t) - VARIANT 20



SYMBOL	MILLIMETRES	
STIVIBOL	MIN	MAX
Α	4.24	4.75
В	1.02	1.32
B1	0.20	0.30
B2	0.46	0.56
С	2.74	3.65
C1	0.38	0.64
Ød	1.22	1.32
ØD	2.87	3.00
ØD1	1.60	2.00
Q	0.89	1.14
V	0.64	0.89



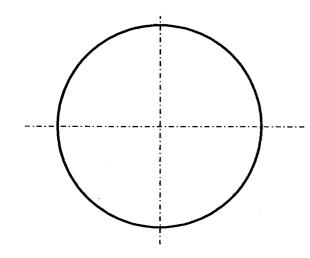


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FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(u) - VARIANTS 21, 36, 49



SYMBOL	MILLIMETRES		
	MIN	MAX	
Α	1.14	1.40	
B1	0.23	0.33	
B2	0.15	0.20	
ØD	1.90	2.16	

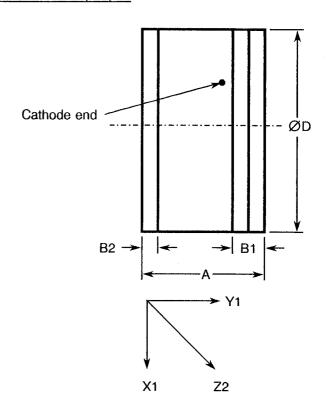
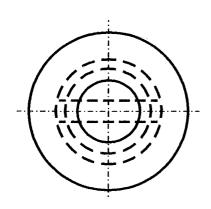
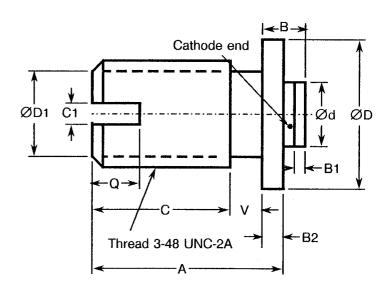
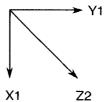


FIGURE 2(v) - VARIANT 22



SYMBOL	MILLIMETRES	
STVIDOL	MIN	MAX
Α	4.04	4.55
В	0.84	1.12
B1	0.20	0.30
B2	0.46	0.56
С	2.54	3.45
C1	0.38	0.64
Ød	1.22	1.32
ØD	2.87	3.00
ØD1	1.60	2.00
Q	0.89	1.14
V	0.64	0.94





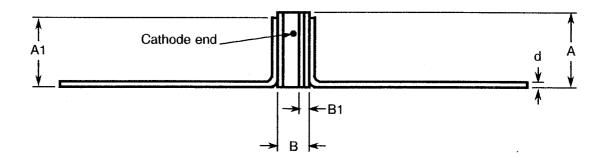


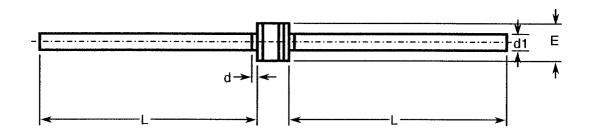
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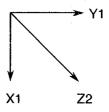
FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(w) - VARIANT 23





SYMBOL	MILLIMETRES	
STWIDOL	MIN	MAX
Α	1.35	2.54
A1 ,	-	2.46
В	1.02	1.27
B1	-	0.38
d	0.07	0.15
d1	0.38	0.64
E	1.29	1.40
L	6.10	12.40



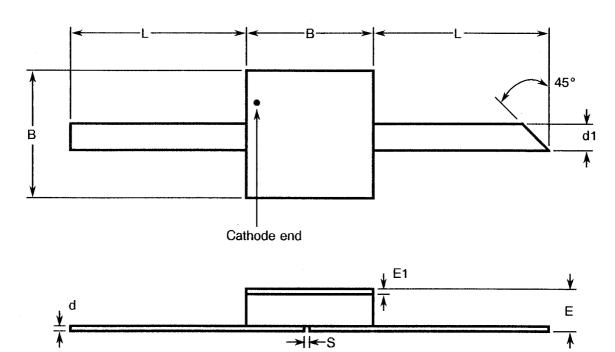


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FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(x) - VARIANTS 24, 37, 50



SYMBOL	MILLIMETRES	
STIVIDOL	MIN	MAX
В	2.39	2.62
d	0.07	0.15
d1	0.48	0.56
E	0.79	1.12
E1	0.10	0.18
L	3.30	5.84
S	0.10	-

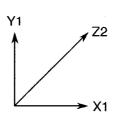


FIGURE 3 - FUNCTIONAL DIAGRAM



- 1. Anode
- 2. Cathode

NOTES

- 1. The cathode end shall be marked with a black dot or band. The marking will not be on the cathode connection but adjacent to it.
- 2. The heatsink end shall be the anode end.



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4. **REQUIREMENTS**

4.1 GENERAL

The complete requirements for procurement of the diodes specified herein shall be as stated in this specification and ESA/SCC Generic Specification No. 5010 for Discrete Microwave Semiconductor Components. Deviations from the Generic Specification applicable to this specification only, are listed in Para. 4.2.

Deviations from the applicable Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESA/SCC requirements and do not affect the components' reliability, are listed in the appendices attached to this specification.

4.2 DEVIATIONS FROM GENERIC SPECIFICATION

4.2.1 <u>Deviations from Special In-process Controls</u>

- (a) Para. 5.2.2, Total Dose Irradiation Testing: Shall be performed during qualification and extension of qualification.
- (b) Para. 5.2.2, Total Dose Irradiation Testing: Shall be performed during procurement on a lot acceptance basis at the total dose irradiation level specified in the purchase order.
- (c) Para. 5.3, Wafer Lot Acceptance: Shall be performed as an S.E.M. Inspection only.

4.2.2 Deviations from Final Production Tests (Chart II)

- (a) Para. 6.2, Pre-burn-in: Shall be performed in accordance with Para. 9.21(a).
- (b) Para. 9.1, Internal Visual Inspection: For Variant 19, the 3 devices prepared for the Bond Strength Test shall be exempt from the maximum height of bond wire above die requirement.
- (c) Para. 9.2.1, Bond Strength: For Variant 19, 3 devices shall have bonds which are long enough to permit this test to be performed.
- (d) Para. 9.2.2, Die Shear: Shall not be performed for Variant 19 and no additional thermal tests shall be performed to replace this test.
- (e) Para. 9.14, Vibration, Variable Frequency: Shall not be performed.

4.2.3 <u>Deviations from Burn-in and Electrical Measurements (Chart III)</u>

(a) Para. 7.1.1(a), High Temperature Reverse Bias Burn-in: Shall be performed at 50% of rated V_R.

4.2.4 Deviations from Qualification Tests (Chart IV)

- (a) Para. 9.2.3, Bond Strength: Shall not be performed for Variant 19.
- (b) Para. 9.2.4, Die Shear: Shall not be performed for Variant 19 for which thermal resistance measurements shall be made in accordance with Table 2 of this specification.
- (c) Para. 9.23, Special Testing: Shall not be performed.

4.2.5 <u>Deviations from Lot Acceptance Tests (Chart V)</u>

(a) Para. 9.23, Special Testing: Shall not be performed.



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4.3 <u>MECHANICAL AND ENVIRONMENTAL REQUIREMENTS</u>

4.3.1 <u>Dimension Check</u>

The dimensions of the diodes specified herein shall be checked. They shall conform to those shown in Figure 2.

4.3.2 Weight

The maximum weight of the diodes specified herein shall be:

Variant No.	Weight (g)
01, 25, 38	0.12
02, 26, 39	0.06
03, 27, 40	0.08
04, 28, 41	2.14
05, 29, 42	0.10
06, 30, 43	1.10
07, 31, 44	1.80
08, 32, 45	0.11
09, 33, 46	0.13
10	0.013
11	0.015
12	0.015

Weight (g)
0.022
0.24
0.14
0.14
0.014
0.12
0.15
0.15
0.08
0.15
0.025
0.06

4.3.3 Terminal Strength

The requirements for terminal strength testing are specified in Section 9 of ESA/SCC Generic Specification No. 5010. The test conditions shall be as follows:-

(a) Condition: 'A' (Tension)

Variant 23:

Force: 1.22N.

- Duration: 5 seconds.

Variants 24, 37 and 50:

- Force: 5.1N.

- Duration: 5 seconds.

(b) Condition: 'D2' (Stud Torque)

Variants 06, 30 and 43:

Torque: 70mNm.

Duration: 5 seconds.



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Variants 14, 15, 34, 35, 47 and 48:

- Torque: 56mNm.

Duration: 5 seconds.

Variants 16, 19, 20 and 22:

Torque: 42mNm.

Duration: 5 seconds.

(c) Condition: Compression

Variants 01, 02, 03, 04, 05, 06, 07, 08, 09, 14, 15, 18, 21, 25, 26, 27, 28, 29, 30, 31, 32, 33, 34, 35, 36, 38, 39, 40, 41, 42, 43, 44, 45, 46, 47, 48 and 49:

Force: 50N.

Duration: 5 seconds.

Variants 10, 11, 12, 13, 16, 17, 20 and 22:

Force: 10N.

Duration: 5 seconds.

Variant 19:

Force: 5N.

- Duration: 5 seconds.

The compression test shall be performed by applying the specified force to the end-cap by means of a suitable weight applied for the specified time. On completion of the test, a visual examination shall be performed to check for damage to the end-cap or the ceramic body.

4.4 MATERIALS AND FINISHES

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the diodes specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material shall not guarantee acceptance of the finished product.

4.4.1 Case

The case shall be hermetically sealed and have a ceramic body. The lid shall be welded or preform soldered.

4.4.2 Lead Materials and Finish

- (a) For Variants 01, 02, 03, 04, 05, 06, 07, 08, 09, 10, 11, 12, 13, 14, 15, 18, 25, 26, 27, 28, 29, 30, 31, 32, 33, 34, 35, 38, 39, 40, 41, 42, 43, 44, 45, 46, 47 and 48, the body material shall be Type 'A' with Type '7' finish and the lid material shall be Type 'D' with Type '2' finish, in accordance with the requirements of ESA/SCC Basic Specification No. 23500.
- (b) For Variants 16, 19, 20, 21, 22, 36 and 49, the lead material shall be Type 'A' with Type '7' finish in accordance with the requirements of ESA/SCC Basic Specification No. 23500.
- (c) For Variants 17, 23, 24, 37 and 50, the lead material shall be Type 'D' with Type '2' finish in accordance with the requirements of ESA/SCC Basic Specification No. 23500.



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4.5 MARKING

4.5.1 General

The marking of components delivered to this specification shall be in accordance with the requirements of ESA/SCC Basic Specification No. 21700 and the following paragraphs. When the component is too small to accommodate all of the marking specified, as much as space permits shall be marked and the marking information, in full, shall accompany the component in its primary package.

The information to be marked and the order of precedence, shall be as follows:-

- (a) Cathode Identification.
- (b) The SCC Component Number.
- (c) Traceability Information.

4.5.2 Cathode Identification

Cathode identification shall be as shown in Figures 2 and 3 of this specification.

4.5.3 The SCC Component Number

Each component shall bear the SCC Component Number which shall be constituted and marked as follows:

	551301901BF
Detail Specification Number ————————————————————————————————————	
Type Variant (see Table 1(a))	
Testing Level (B or C, as applicable)	
Total Dose Irradiation Level (if applicable)	

The Total Dose Irradiation Level designation shall be added for those devices for which a sample has been successfully tested to the level in question. For these devices, a code letter shall be added in accordance with the requirements of ESA/SCC Basic Specification No. 22900.

4.5.4 Traceability Information

Each component shall be marked in respect of traceability information as defined in ESA/SCC Basic Specification No. 21700.

4.6 <u>ELECTRICAL MEASUREMENTS</u>

4.6.1 <u>Electrical Measurements at Room Temperature</u>

The parameters to be measured at room temperature are scheduled in Table 2. Unless otherwise specified, the measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.6.2 <u>Electrical Measurements at High and Low Temperatures</u>

The parameters to be measured at high and low temperatures are scheduled in Table 3. Unless otherwise specified, the measurements shall be performed at $T_{amb} = +150(+0-3)$ °C.

4.6.3 <u>Circuits for Electrical Measurements</u>

Circuits for use in performing electrical measurements listed in Table 2 of this specification are shown in Figure 4.



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4.7 BURN-IN TESTS

Burn-in shall be Category 3 of Chart III(a).

4.7.1 Parameter Drift Values

The parameter drift values applicable to burn-in are specified in Table 4 of this specification. Unless otherwise stated, the measurements shall be performed at T_{amb} = +22±3 °C. The parameter drift values (Δ) applicable to the scheduled parameters shall not be exceeded. In addition to these drift value requirements for a given parameter, the appropriate limit value specified in Table 2 shall not be exceeded.

4.7.2 Conditions for High Temperature Reverse Bias Burn-in

The requirements for the high temperature reverse bias burn-in are specified in Section 7 of ESA/SCC Generic Specification No. 5010. The conditions for high temperature reverse bias burn-in shall be as specified in Table 5(a) of this specification.

4.7.3 Conditions for Power Burn-in

The requirements for power burn-in are specified in Section 7 of ESA/SCC Generic Specification No. 5010. The conditions for power burn-in shall be as specified in Table 5(b) of this specification.

4.7.4 <u>Electrical Circuits for High Temperature Reverse Bias and Power Burn-in</u>

Circuits for use in performing the H.T.R.B and power burn-in tests are shown in Figures 5(a) and 5(b) of this specification.



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TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE - D.C. PARAMETERS

AL CHARACTERISTICS	CVAADOL	MIL-STD-750	TEST COMPUTIONS	LIN	11007		
No.	CHARACTERISTICS	SYMBOL	TEST METHOD	TEST CONDITIONS	MIN.	MAX.	UNIT
1	Reverse Current 1	I _{R1}	4016	V _R = -200V	-	10	μΑ
2	Reverse Current 2	I _{R2}	4016	V _R = -100V	-	50	nA
3	Forward Voltage	V _F	4011	I _F = 100mA	-	1.3	V
4	Thermal Resistance	R _{TH(J-C)}	3101	I _F = 1.0A Note 1 Variants 01 to 23 Variant 24 Variants 25 to 36 Variant 37 Variants 38 to 49 Variant 50		40 200 35 195 30 190	°C/W

NOTES

1. Pulsed measurement, pulse width = $4.0\mu s$, p.r.f. = 1.0kHz.

TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE - A.C. PARAMETERS

No	CHADACTEDISTICS	SYMBOL	MIL-STD-750	IIL-STD-750 TEST TEST	LIMITS		UNIT	
NO.	No. CHARACTERISTICS	STWIBUL	TEST METHOD	FIG.	CONDITIONS	MIN.	MAX.	ONI
5	Total Capacitance	C _T	4001	-	V _R = -10V f = 1.0MHz	Not	te 1	pF
6	Minority Carrier Lifetime	τ∟	-	4(a)	I _F = 4.5mA	-	1.2	μs
7	Forward Slope Resistance	R _{FS}	-	4(b)	$I_F = 40 \text{mA}$ $f_0 = 500 \text{MHz}$ Variants 01 to 24 Variants 25 to 37 Variants 38 to 50		1.3 1.0 0.8	Ω

NOTES

1. See Column 4 of Table 1(a).



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TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES

No. CHARACTERISTICS	SVMBOI	SPEC.AND/OR TEST METHOD	TEST CONDITIONS	LIMITS		UNIT	
	STWIDOL		TEST CONDITIONS	MIN.	MAX.	OINT	
2	Reverse Current 2	I _{R2}	As per Table 2	As per Table 2	-	10	μΑ

TABLE 4 - PARAMETER DRIFT VALUES

No.	CHARACTERISTICS	SYMBOL	SPEC.AND/OR TEST METHOD	TEST CONDITIONS	CHANGE LIMITS (Δ)	UNIT
2	Reverse Current 2	I _{R2}	As per Table 2	As per Table 2	±10 (1) or (2) ±100 (1)	nA %
3	Forward Voltage	V _F	As per Table 2	As per Table 2	± 100 (1)	mV

NOTES

- 1. $\Delta 1 = \Delta 2 = \Delta 3$.
- 2. Whichever is the greater, referred to the initial measurement.



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FIGURE 4 - CIRCUITS FOR ELECTRICAL MEASUREMENTS

FIGURE 4(a) - MINORITY CARRIER LIFETIME

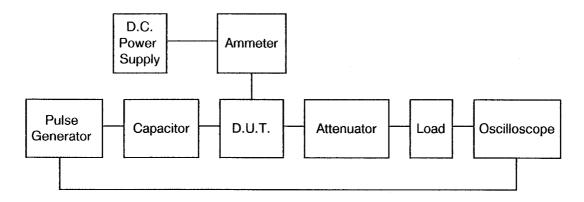
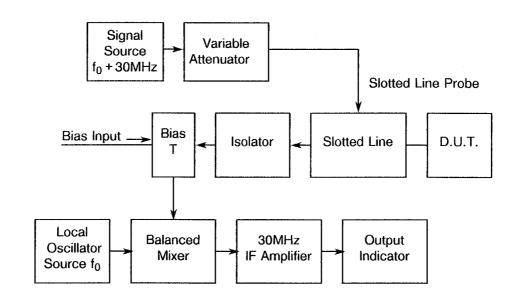


FIGURE 4(b) - FORWARD SLOPE RESISTANCE





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TABLE 5(a) - CONDITIONS FOR HIGH TEMPERATURE REVERSE BIAS BURN-IN

No.	CHARACTERISTICS	SYMBOL	CONDITIONS	UNIT
1	Ambient Temperature	T _{amb}	+ 150(+ 0 - 3)	°C
2	Reverse Voltage	V _R	- 100	٧

TABLE 5(b) - CONDITIONS FOR POWER BURN-IN

No.	CHARACTERISTICS	SYMBOL	CONDITIONS	UNIT
1	Ambient Temperature	T _{amb}	+ 125(+ 0 - 3)	°C
2	Forward Current	l _E	100	mA

TABLE 5(c) - CONDITIONS FOR OPERATING LIFE TESTS

No.	CHARACTERISTICS	SYMBOL	CONDITIONS	UNIT
1	Ambient Temperature 1	T _{amb1}	+115(+0-3)	°C
2	Forward Current 1	l _{F1}	100	mA
3	Ambient Temperature 2	T _{amb2}	+ 125(+ 0 - 3)	°C
4	Forward Current 2	I _{F2}	100	mA

FIGURE 5(a) - ELECTRICAL CIRCUIT FOR HIGH TEMPERATURE REVERSE BIAS BURN-IN

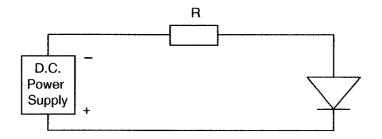
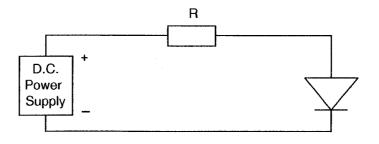


FIGURE 5(b) - ELECTRICAL CIRCUIT FOR POWER BURN-IN AND OPERATING LIFE TESTS





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4.8 <u>ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESA/SCC GENERIC</u> SPECIFICATION NO. 5010)

4.8.1 Electrical Measurements on Completion of Environmental Tests

The parameters to be measured on completion of environmental tests are scheduled in Table 2. Unless otherwise stated, the measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.8.2 Electrical Measurements at Intermediate Points and on Completion of Endurance Tests

The parameters to be measured at intermediate points and on completion of endurance tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.8.3 Conditions for Operating Life Tests (Part of Endurance Testing)

The requirements for operating life testing are specified in Section 9 of ESA/SCC Generic Specification No. 5010. The conditions for operating life testing are specified in Table 5(c) of this specification.

4.8.4 Electrical Circuits for Operating Life Tests

The circuit to be used for performance of the operating life test shall be the same as shown in Figure 5(b) for Power Burn-in.

4.9 TOTAL DOSE IRRADIATION TESTING

4.9.1 Application

If specified in Para. 4.2.1 of this specification, total dose irradiation testing shall be performed in accordance with the requirements of ESA/SCC Basic Specification No. 22900.

4.9.2 Bias Conditions

Continuous bias shall be applied during irradiation testing as shown in Figure 6 of this specification.

4.9.3 <u>Electrical Measurements</u>

The parameters to be measured prior to irradiation exposure are scheduled in Table 2 of this specification. Only devices which meet the requirements of Table 2 shall be included in the test sample.

The parameters to be measured during and on completion of irradiation testing are scheduled in Table 7 of this specification.

4.10 SPECIAL TESTING

Not applicable.



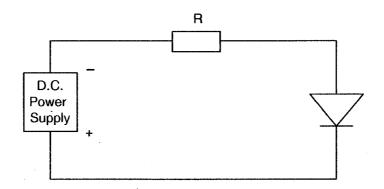
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TABLE 6 - ELECTRICAL MEASUREMENTS AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING

No	No. CHARACTERISTICS SY	SYMBOL	SPEC. AND/OR	TEST CONDITIONS	LIMITS		LINUT
INO.		STIVIBUL	TEST METHOD	TEST CONDITIONS	MIN.	MAX.	UNIT
1	Reverse Current 1	l _{R1}	As per Table 2	As per Table 2	As per	Table 2	μА
2	Reverse Current 2	I _{R2}	As per Table 2	As per Table 2	As per	Table 2	nA
3	Forward Voltage	V _F	As per Table 2	As per Table 2	As per	Table 2	٧
5	Total Capacitance	C _T	As per Table 2	As per Table 2	As per	Table 2	pF
7	Forward Slope Resistance	R _{FS}	As per Table 2	As per Table 2	As per	Table 2	Ω

FIGURE 6 - BIAS CONDITIONS FOR IRRADIATION TESTING



NOTES

1. A reverse bias of $V_R = -100V$ shall be applied.



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TABLE 7 - ELECTRICAL MEASUREMENTS DURING AND ON COMPLETION OF IRRADIATION TESTING

No.	CHARACTERISTICS	SYMBOL	SPEC. AND/OR TEST METHOD	TEST CONDITIONS	CHANGE LIMITS (Δ)	UNIT
6	Minority Carrier Lifetime	ፒլ	As per Table 2	As per Table 2	Note 1	%

NOTES

1. The graph given below shall be used to determine the maximum permitted change.

